

Silicon Transistor

2SC5336

NPN EPITAXIAL SILICON TRANSISTOR HIGH FREQUENCY LOW DISTORTION AMPLIFIER

FEATURES

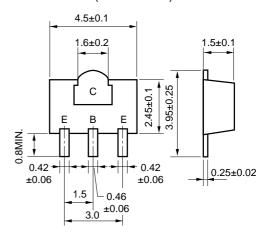
- High gain
 - $|S_{21}|^2$ = 12 dB TYP, @f = 1 GHz, V_{CE} = 10 V, Ic = 20 mA
- New power mini-mold package version of a 4-pin type gain-improved on the 2SC3357

ABSOLUTE MAXIMUM RATINGS $(T_A = 25 \text{ °C})$

Parameter	Symbol	Rating	Unit
Collector to Base Voltage	V _{CBO}	20	V
Collector to Emitter Voltage	V _{CEO}	12	V
Emitter to Base Voltage	V _{EBO} 3.0		V
Collector Current	Ic	100	mA
Total Power Dissipation	P _T Note1	1.2	W
Junction Temperature	Tj	150	°C
Storage Temperature	T _{stg}	-65 to +150	°C

PACKAGE DIMENSIONS

(in millimeters)



Note 1. $0.7 \text{ mm} \times 16 \text{ cm}^2$ double sided ceramic substrate (Copper plating)

PIN CONNECTIONS

E: Emitter

C: Collector

B: Base

ELECTRICAL CHARACTERISTICS (T_A = 25 °C)

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Collector Cutoff Current	I _{CB0}	V _{CB} = 10 V, I _E = 0			1.0	μΑ
Emitter Cutoff Current	I _{EB0}	V _{EB} = 1 V, I _C = 0			1.0	μΑ
DC Current Gain	h _{FE}	$V_{CE} = 10 \text{ V}, I_{C} = 20 \text{ mA}^{\text{Note2}}$	50	120	250	
Gain Bandwidth Product	f _T	V _{CE} = 10 V, I _C = 20 mA		6.5		GHz
Feed-back Capacitance	C _{re}	$V_{CB} = 10 \text{ V}, I_{E} = 0, f = 1.0 \text{ MHz}^{\text{Note3}}$		0.5	0.8	pF
Insertion Power Gain	S _{21e} ²	V _{CE} = 10 V, I _C = 20 mA, f = 1.0 GHz		12.0		dB
Noise Figure	NF	V _{CE} = 10 V, I _C = 7 mA, f = 1.0 GHz		1.1		dB
Noise Figure	NF	V _{CE} = 10 V, I _C = 40 mA, f = 1.0 GHz		1.8	3.0	dB

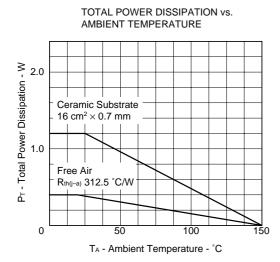
Notes 2. Pulse measurement : PW \leq 350 μ S, Duty Cycle \leq 2 %

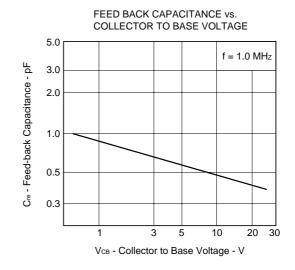
3. Mesured by a 3-terminal bridge. Emitter and Case should be connected to the guard terminal.

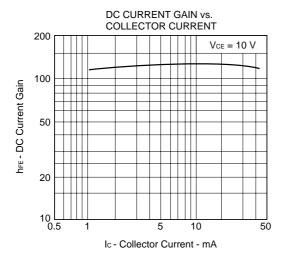
h_{FE} Classification

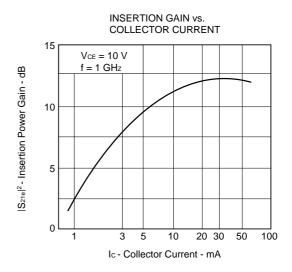
Rank	RH	RF	RE
Marking	RH	RF	RE
h _{FE}	50 to 100	80 to 160	125 to 250

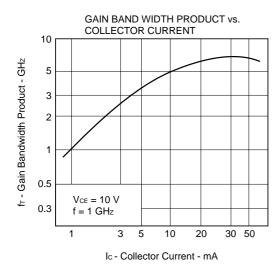
TYPICAL CHARACTERISTICS (T_A = 25 °C)

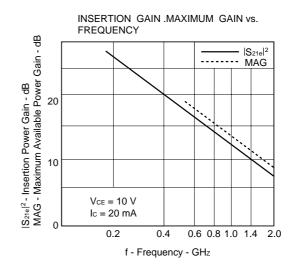






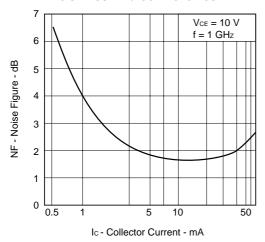




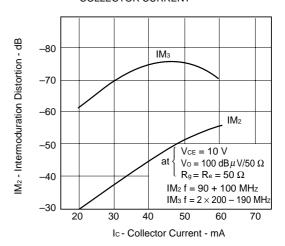


NEC 2SC5336

NOISE FIGURE vs. COLLECTOR CURRENT



INTERMODULATION DISTORTION vs. COLLECTOR CURRENT





S-PARAMETER

 $V_{CE} = 10 \text{ V}, I_{C} = 20 \text{ mA}$

	S ₁₁			S ₂₁		S ₁₂		S ₂₂		
f (MHz)	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG		
100	.519	- 74.5	30.931	131.9	.017	60.6	.752	- 30.2		
200	.413	- 112.9	18.965	111.5	.031	61.9	.570	- 39.7		
300	.413	- 133.4	13.324	101.9	.038	65.1	.465	- 39.8		
400	.345	- 145.7	10.164	95.9	.045	69.8	.428	- 40.1		
500	.331	- 153.8	8.177	91.8	.055	71.8	.436	- 41.1		
600	.320	- 159.6	6.834	89.1	.064	70.9	.438	- 43.5		
700	.302	- 166.8	5.832	86.7	.074	73.9	.434	- 47.5		
800	.296	- 169.2	5.107	84.3	.077	74.4	.429	- 47.8		
900	.283	- 173.2	4.600	83.1	.088	71.2	.436	- 46.5		
1000	.285	- 179.8	4.200	82.3	.097	74.5	.455	- 47.8		
1100	.265	175.2	3.930	80.8	.100	76.3	.467	- 46.8		
1200	.260	174.1	3.979	78.5	.109	75.9	.529	- 47.4		
1300	.263	166.0	3.741	68.6	.114	76.8	.551	- 55.8		
1400	.242	163.0	3.115	66.6	.119	78.3	.509	- 55.8		
1500	.252	160.1	2.844	65.7	.133	82.0	.510	- 58.5		
1600	.253	154.0	2.595	64.1	.140	81.0	.496	- 55.2		
1700	.253	149.9	2.420	63.7	.158	80.9	.515	- 54.8		
1800	.257	147.2	2.305	63.0	.165	82.2	.518	- 56.5		
1900	.262	143.0	2.171	62.6	.172	80.5	.536	- 58.6		
2000	.273	141.5	2.049	61.2	.177	78.3	.524	- 61.5		



S-PARAMETER

 V_{CE} = 10 V, I_C = 40 mA

	S ₁₁			S ₂₁		S ₁₂		S ₂₂	
f (MHz)	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG	
100	.378	- 97.1	32.908	123.3	.017	71.1	.665	- 34.7	
200	.317	- 131.8	18.819	106.0	.027	71.2	.487	- 38.7	
300	.308	- 150.1	12.955	97.5	.035	71.8	.398	- 38.5	
400	.299	- 158.7	9.775	93.1	.042	78.1	.393	- 36.9	
500	.297	- 165.5	7.899	89.8	.052	78.5	.399	- 37.6	
600	.288	- 169.2	6.586	87.6	.061	79.1	.407	- 39.9	
700	.274	- 173.7	5.607	85.2	.071	77.4	.400	- 44.6	
800	.261	- 177.3	4.879	83.5	.081	76.4	.415	- 47.4	
900	.255	178.9	4.435	82.2	.092	76.5	.399	- 46.2	
1000	.260	173.0	4.024	81.4	.095	77.6	.440	- 44.3	
1100	.243	169.4	3.801	80.6	.098	77.1	.441	- 45.2	
1200	.239	169.3	3.827	78.2	.109	78.3	.494	- 46.2	
1300	.245	160.3	3.587	68.4	.117	78.0	.517	- 55.4	
1400	.216	157.8	2.980	66.0	.125	80.3	.486	- 54.5	
1500	.235	155.3	2.726	66.1	.137	86.5	.500	- 59.0	
1600	.243	148.8	2.537	64.0	.143	80.6	.474	- 53.7	
1700	.233	146.0	2.348	64.2	.159	81.2	.496	- 56.8	
1800	.242	144.6	2.200	63.5	.163	80.4	.491	- 53.6	
1900	.249	141.9	2.073	63.3	.171	81.7	.534	- 58.0	
2000	.260	140.4	1.986	61.7	.184	77.5	.535	- 61.3	

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